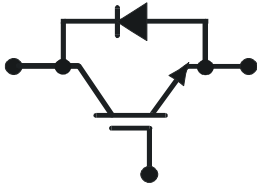


$V_{CE} = 6500 \text{ V}$
 $I_C = 600 \text{ A}$

ABB HiPak™

IGBT Module
5SNA 0600G650100



Doc. No. 5SYA1558-02 Jan 06

- Low-loss, rugged SPT chip-set
- Smooth switching SPT chip-set for good EMC
- High insulation package
- AISiC base-plate for high power cycling capability
- AlN substrate for low thermal resistance



Maximum rated values ¹⁾

Parameter	Symbol	Conditions	min	max	Unit
Collector-emitter voltage	V_{CES}	$V_{GE} = 0 \text{ V}, T_{vj} \geq 25 \text{ °C}$		6500	V
DC collector current	I_C	$T_c = 85 \text{ °C}$		600	A
Peak collector current	I_{CM}	$t_p = 1 \text{ ms}, T_c = 85 \text{ °C}$		1200	A
Gate-emitter voltage	V_{GES}		-20	20	V
Total power dissipation	P_{tot}	$T_c = 25 \text{ °C}, \text{ per switch (IGBT)}$		11900	W
DC forward current	I_F			600	A
Peak forward current	I_{FRM}			1200	A
Surge current	I_{FSM}	$V_R = 0 \text{ V}, T_{vj} = 125 \text{ °C},$ $t_p = 10 \text{ ms}, \text{ half-sinewave}$		6000	A
IGBT short circuit SOA	t_{psc}	$V_{CC} = 4400 \text{ V}, V_{CEMCHIP} \leq 6500 \text{ V}$ $V_{GE} \leq 15 \text{ V}, T_{vj} \leq 125 \text{ °C}$		10	μs
Isolation voltage	V_{isol}	1 min, $f = 50 \text{ Hz}$		10200	V
Junction temperature	T_{vj}			125	°C
Junction operating temperature	$T_{vj(op)}$		-40	125	°C
Case temperature	T_c		-40	125	°C
Storage temperature	T_{stg}		-40	125	°C
Mounting torques ²⁾	M_s	Base-heatsink, M6 screws	4	6	Nm
	M_{t1}	Main terminals, M8 screws	8	10	
	M_{t2}	Auxiliary terminals, M4 screws	2	3	

¹⁾ Maximum rated values indicate limits beyond which damage to the device may occur per IEC 60747

²⁾ For detailed mounting instructions refer to ABB Document No. 5SYA2039

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IGBT characteristic values ³⁾

Parameter	Symbol	Conditions	min	typ	max	Unit
Collector (-emitter) breakdown voltage	$V_{(BR)CES}$	$V_{GE} = 0 \text{ V}$, $I_C = 10 \text{ mA}$, $T_{vj} = 25 \text{ °C}$	6500			V
Collector-emitter ⁴⁾ saturation voltage	$V_{CE \text{ sat}}$	$I_C = 600 \text{ A}$, $V_{GE} = 15 \text{ V}$		4.2	4.8	V
		$T_{vj} = 25 \text{ °C}$				
		$T_{vj} = 125 \text{ °C}$		5.4	5.9	V
Collector cut-off current	I_{CES}	$V_{CE} = 6500 \text{ V}$, $V_{GE} = 0 \text{ V}$			12	mA
		$T_{vj} = 25 \text{ °C}$				
		$T_{vj} = 125 \text{ °C}$		70	120	mA
Gate leakage current	I_{GES}	$V_{CE} = 0 \text{ V}$, $V_{GE} = \pm 20 \text{ V}$, $T_{vj} = 125 \text{ °C}$	-500		500	nA
Gate-emitter threshold voltage	$V_{GE(TO)}$	$I_C = 240 \text{ mA}$, $V_{CE} = V_{GE}$, $T_{vj} = 25 \text{ °C}$	6.5	7.4	8.0	V
Gate charge	Q_{ge}	$I_C = 600 \text{ A}$, $V_{CE} = 3600 \text{ V}$, $V_{GE} = -15 \text{ V} .. 15 \text{ V}$		8.0		μC
Input capacitance	C_{ies}	$V_{CE} = 25 \text{ V}$, $V_{GE} = 0 \text{ V}$, $f = 1 \text{ MHz}$, $T_{vj} = 25 \text{ °C}$		143		nF
Output capacitance	C_{oes}			6.62		
Reverse transfer capacitance	C_{res}			1.27		
Turn-on delay time	$t_{d(on)}$	$V_{CC} = 3600 \text{ V}$, $I_C = 600 \text{ A}$, $R_G = 3.9 \text{ }\Omega$,				ns
		$V_{GE} = \pm 15 \text{ V}$, $L_\sigma = 280 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ °C}$	640		
			$T_{vj} = 125 \text{ °C}$	570		
Rise time	t_r	$V_{GE} = \pm 15 \text{ V}$, $L_\sigma = 280 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ °C}$	270		ns
			$T_{vj} = 125 \text{ °C}$	240		
Turn-off delay time	$t_{d(off)}$	$V_{CC} = 3600 \text{ V}$, $I_C = 600 \text{ A}$, $R_G = 3.9 \text{ }\Omega$,	$T_{vj} = 25 \text{ °C}$	1540		ns
		$V_{GE} = \pm 15 \text{ V}$, $L_\sigma = 280 \text{ nH}$, inductive load	$T_{vj} = 125 \text{ °C}$	1860		
Fall time	t_f	$V_{GE} = \pm 15 \text{ V}$, $L_\sigma = 280 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ °C}$	620		ns
			$T_{vj} = 125 \text{ °C}$	960		
Turn-on switching energy	E_{on}	$V_{CC} = 3600 \text{ V}$, $I_C = 600 \text{ A}$, $V_{GE} = \pm 15 \text{ V}$, $R_G = 3.9 \text{ }\Omega$, $L_\sigma = 280 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ °C}$	3800		mJ
			$T_{vj} = 125 \text{ °C}$	4900		
Turn-off switching energy	E_{off}	$V_{CC} = 3600 \text{ V}$, $I_C = 600 \text{ A}$, $V_{GE} = \pm 15 \text{ V}$, $R_G = 3.9 \text{ }\Omega$, $L_\sigma = 280 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ °C}$	1950		mJ
			$T_{vj} = 125 \text{ °C}$	3150		
Short circuit current	I_{SC}	$t_{psc} \leq 10 \text{ }\mu\text{s}$, $V_{GE} = 15 \text{ V}$, $T_{vj} = 125 \text{ °C}$, $V_{CC} = 4400 \text{ V}$, $V_{CEM \text{ CHIP}} \leq 6500 \text{ V}$		2700		A
Module stray inductance	$L_{\sigma \text{ CE}}$			18		nH
Resistance, terminal-chip	$R_{CC'+EE'}$		$T_C = 25 \text{ °C}$	0.07		m Ω
			$T_C = 125 \text{ °C}$	0.1		

³⁾ Characteristic values according to IEC 60747 – 9⁴⁾ Collector-emitter saturation voltage is given at chip level

Diode characteristic values ⁵⁾

Parameter	Symbol	Conditions	min	typ	max	Unit
Forward voltage ⁶⁾	V_F	$I_F = 600 \text{ A}$	$T_{vj} = 25 \text{ °C}$	3.2	3.8	V
			$T_{vj} = 125 \text{ °C}$	3.4	4.0	
Reverse recovery current	I_{rr}	$V_{CC} = 3600 \text{ V},$ $I_F = 600 \text{ A},$ $V_{GE} = \pm 15 \text{ V},$ $R_G = 3.9 \text{ } \Omega$ $L_\sigma = 280 \text{ nH}$ inductive load	$T_{vj} = 25 \text{ °C}$	790		A
			$T_{vj} = 125 \text{ °C}$	990		
Recovered charge	Q_{rr}	$V_{CC} = 3600 \text{ V},$ $I_F = 600 \text{ A},$ $V_{GE} = \pm 15 \text{ V},$ $R_G = 3.9 \text{ } \Omega$ $L_\sigma = 280 \text{ nH}$ inductive load	$T_{vj} = 25 \text{ °C}$	700		μC
			$T_{vj} = 125 \text{ °C}$	1200		
Reverse recovery time	t_{rr}	$V_{CC} = 3600 \text{ V},$ $I_F = 600 \text{ A},$ $V_{GE} = \pm 15 \text{ V},$ $R_G = 3.9 \text{ } \Omega$ $L_\sigma = 280 \text{ nH}$ inductive load	$T_{vj} = 25 \text{ °C}$	1700		ns
			$T_{vj} = 125 \text{ °C}$	2200		
Reverse recovery energy	E_{rec}	$V_{CC} = 3600 \text{ V},$ $I_F = 600 \text{ A},$ $V_{GE} = \pm 15 \text{ V},$ $R_G = 3.9 \text{ } \Omega$ $L_\sigma = 280 \text{ nH}$ inductive load	$T_{vj} = 25 \text{ °C}$	1100		mJ
			$T_{vj} = 125 \text{ °C}$	2200		

⁵⁾ Characteristic values according to IEC 60747 – 2

⁶⁾ Forward voltage is given at chip level

Package properties ⁷⁾

Parameter	Symbol	Conditions	min	typ	max	Unit
IGBT thermal resistance junction to case	$R_{th(j-c)IGBT}$				0.011	K/W
Diode thermal resistance junction to case	$R_{th(j-c)DIODE}$				0.021	K/W
Thermal resistance case ²⁾ to heatsink	$R_{th(c-s)}$	per module, λ grease = $1\text{W/m} \times \text{K}$		0.006		K/W
Partial discharge extinction voltage	V_e	$f = 50 \text{ Hz}, Q_{PD} \leq 10\text{pC}$ (acc. to IEC 61287)	5100			V
Comparative tracking index	CTI			≥ 600		

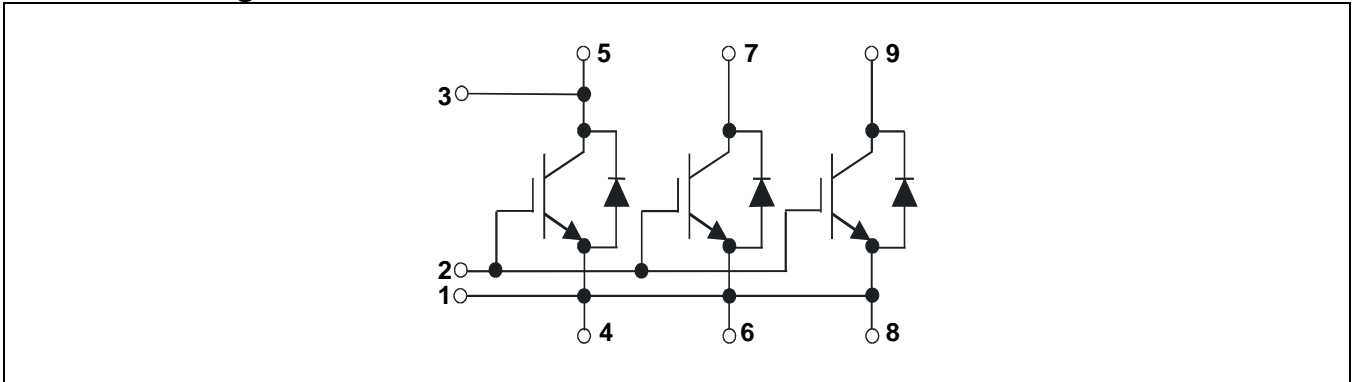
²⁾ For detailed mounting instructions refer to ABB Document No. 5SYA2039

Mechanical properties ⁷⁾

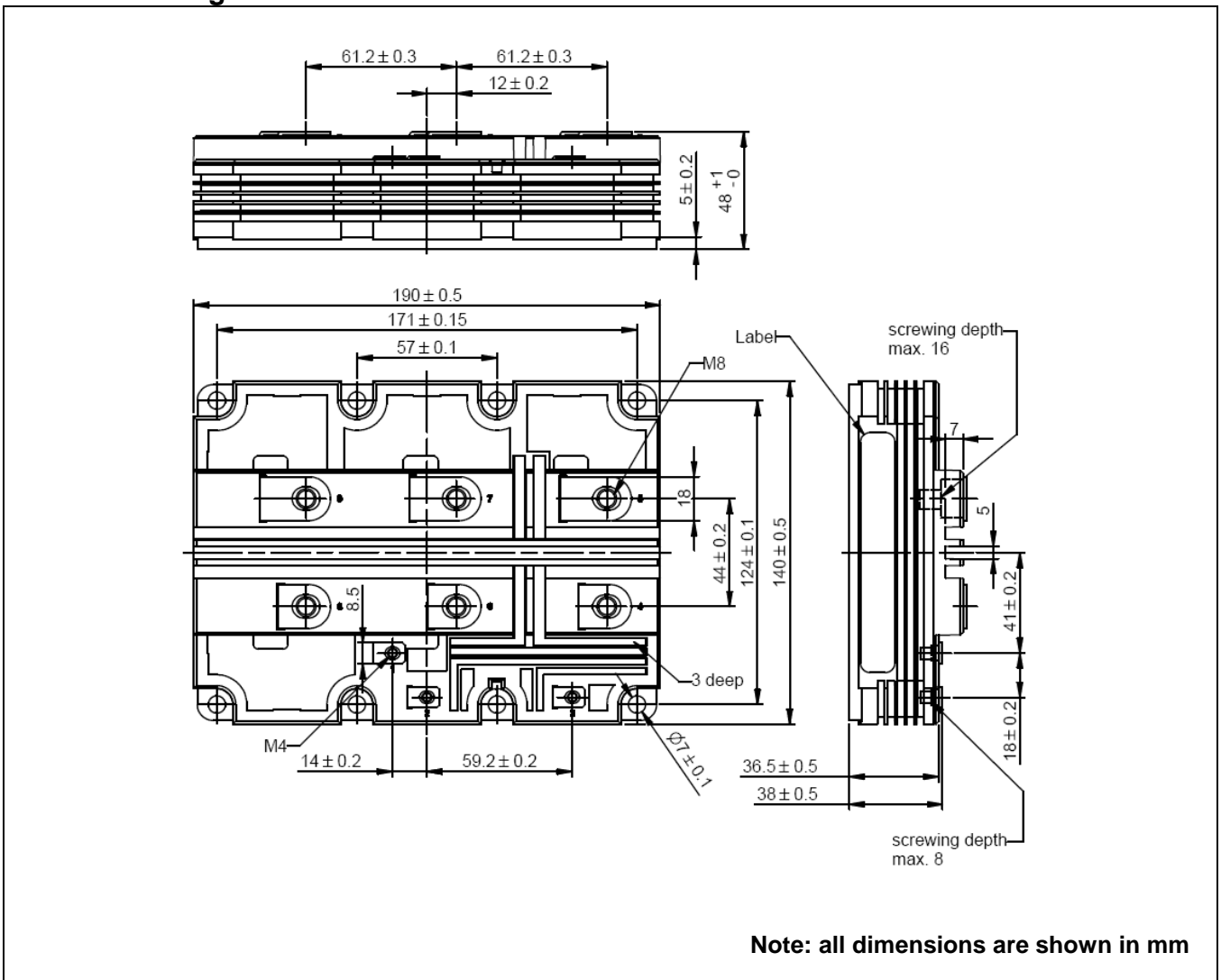
Parameter	Symbol	Conditions	min	typ	max	Unit
Dimensions	$L \times W \times H$	Typical , see outline drawing	190 × 140 × 48			mm
Clearance distance in air	d_a	according to IEC 60664-1 and EN 50124-1	Term. to base:	40		mm
			Term. to term:	26		
Surface creepage distance	d_s	according to IEC 60664-1 and EN 50124-1	Term. to base:	64		mm
			Term. to term:	56		
Mass	m			1760		g

⁷⁾ Package and mechanical properties according to IEC 60747 – 15

Electrical configuration



Outline drawing ²⁾



²⁾ For detailed mounting instructions refer to ABB Document No. 5SYA2039

This is an electrostatic sensitive device, please observe the international standard IEC 60747-1, chap. IX.

This product has been designed and qualified for Industrial Level.

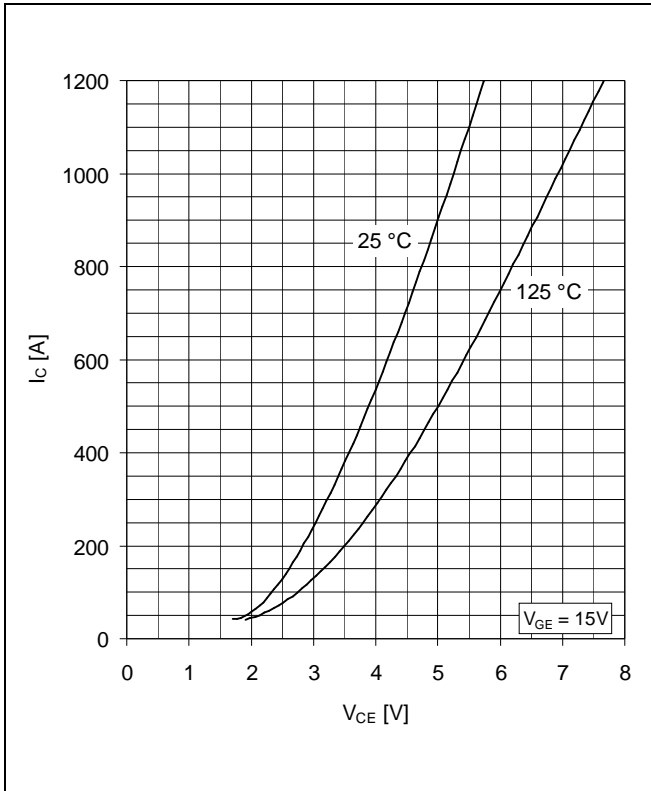


Fig. 1 Typical on-state characteristics, chip level

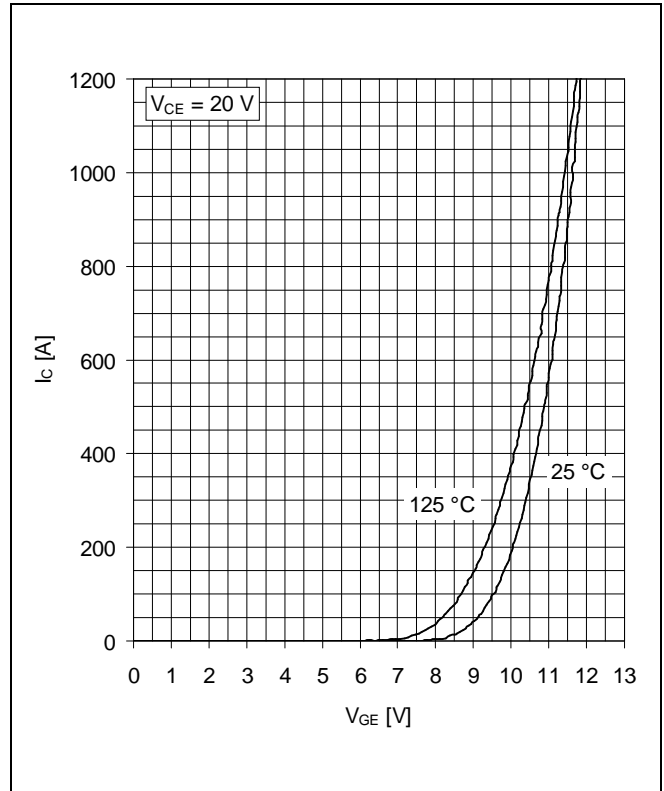


Fig. 2 Typical transfer characteristics, chip level

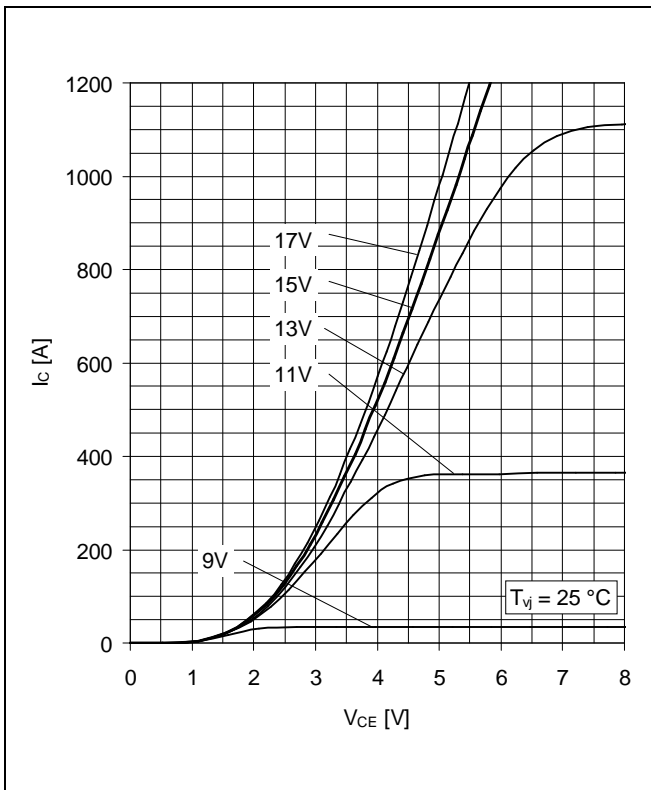


Fig. 3 Typical output characteristics, chip level

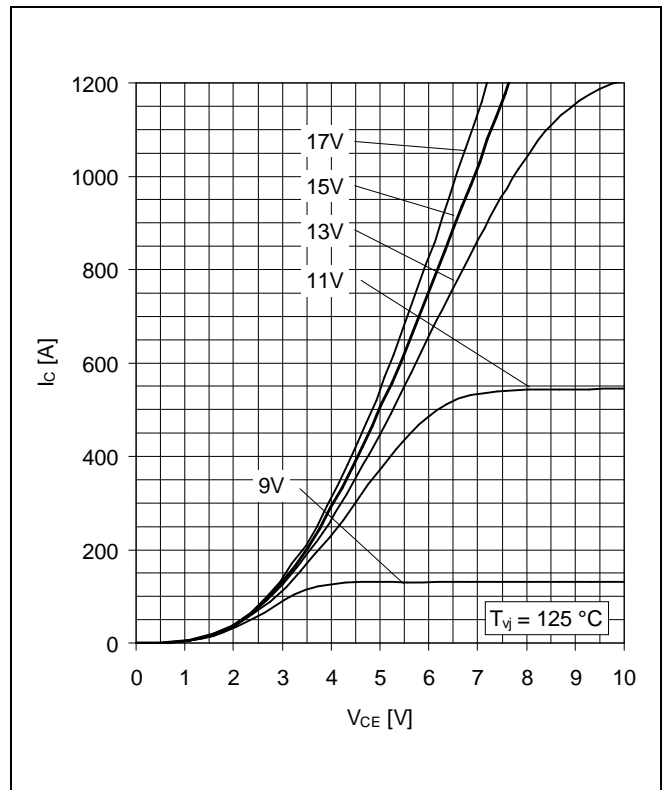


Fig. 4 Typical output characteristics, chip level

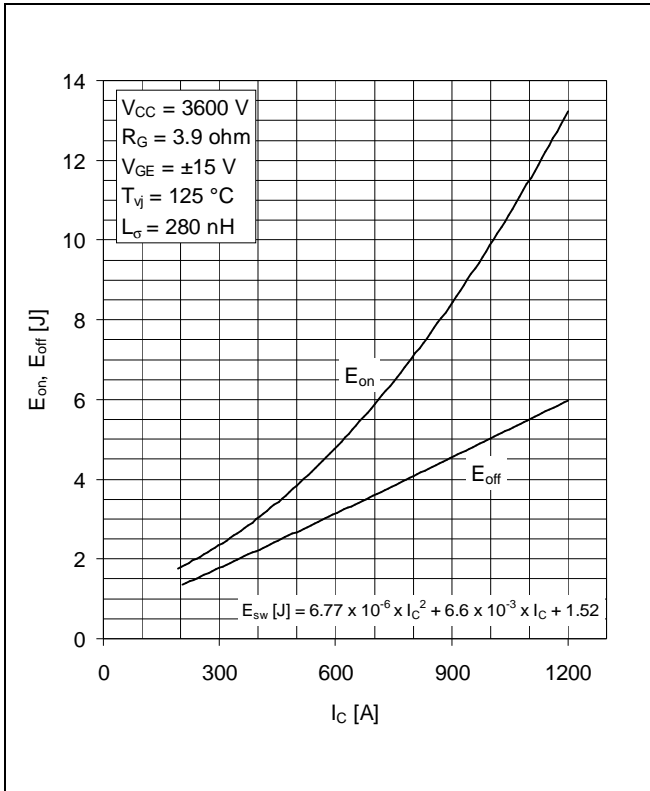


Fig. 5 Typical switching energies per pulse vs collector current

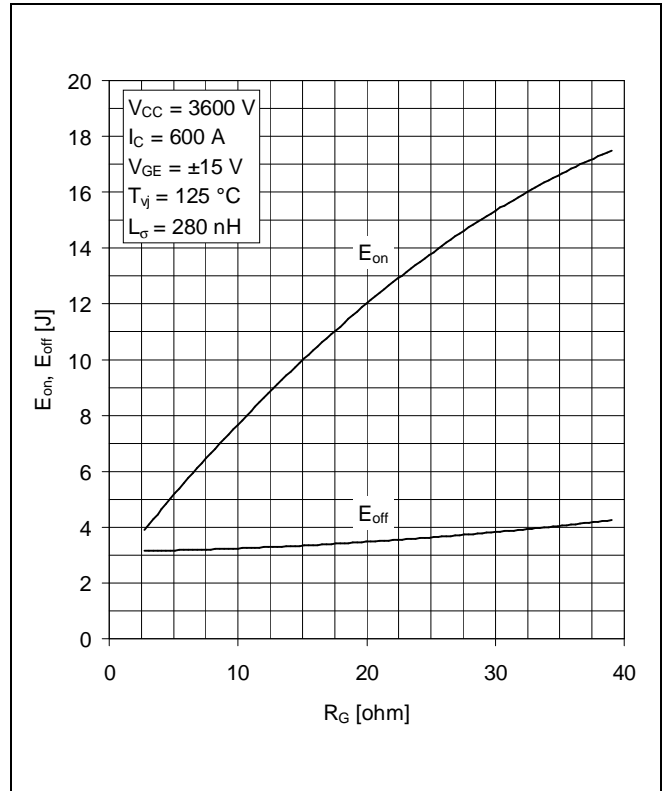


Fig. 6 Typical switching energies per pulse vs gate resistor

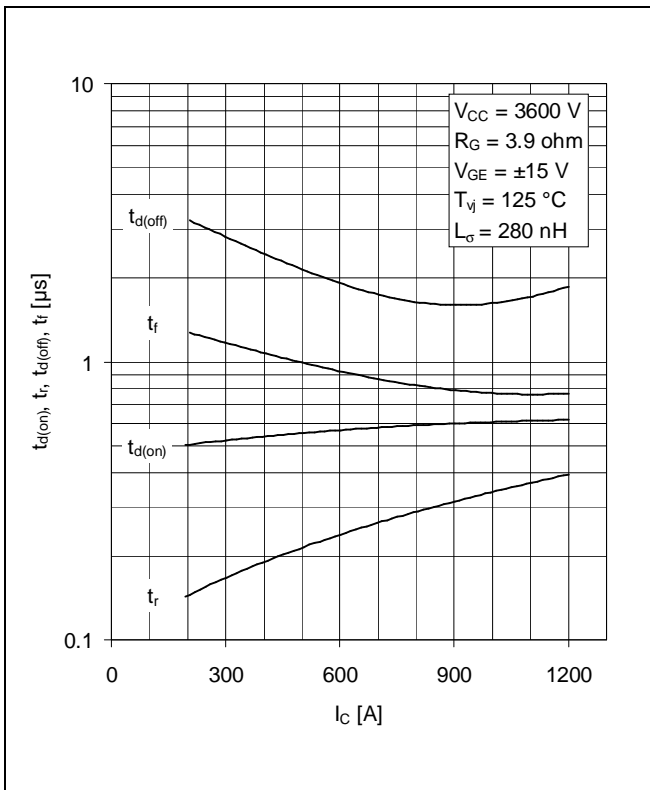


Fig. 7 Typical switching times vs collector current

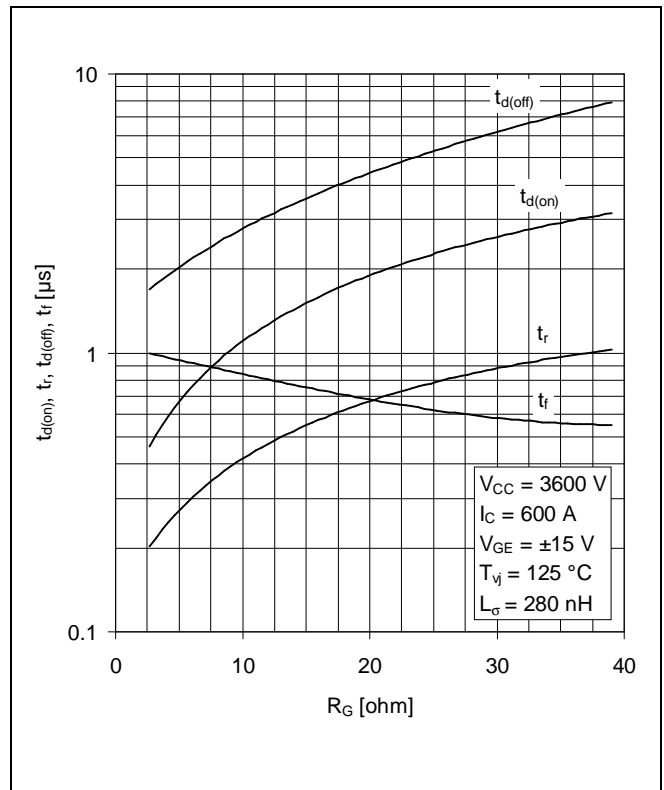


Fig. 8 Typical switching times vs gate resistor

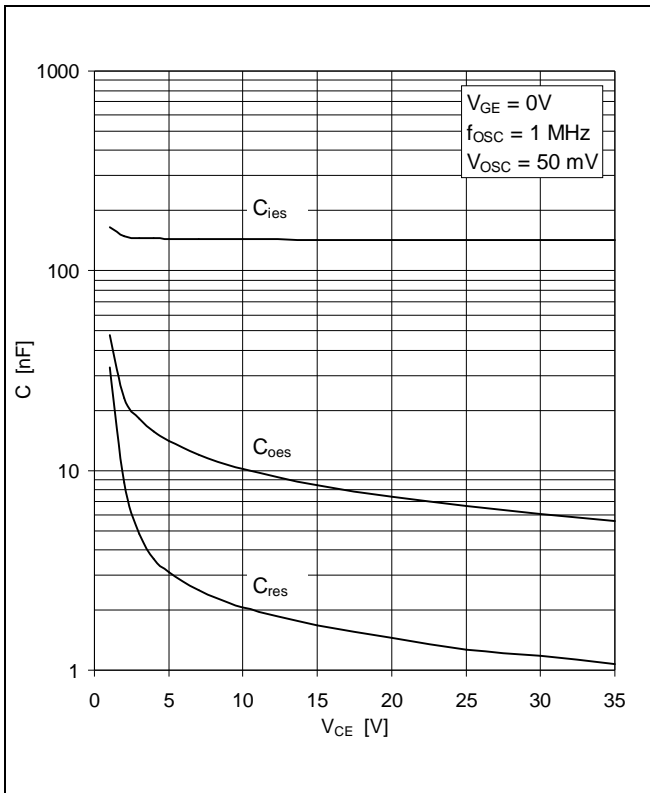


Fig. 9 Typical capacitances vs collector-emitter voltage

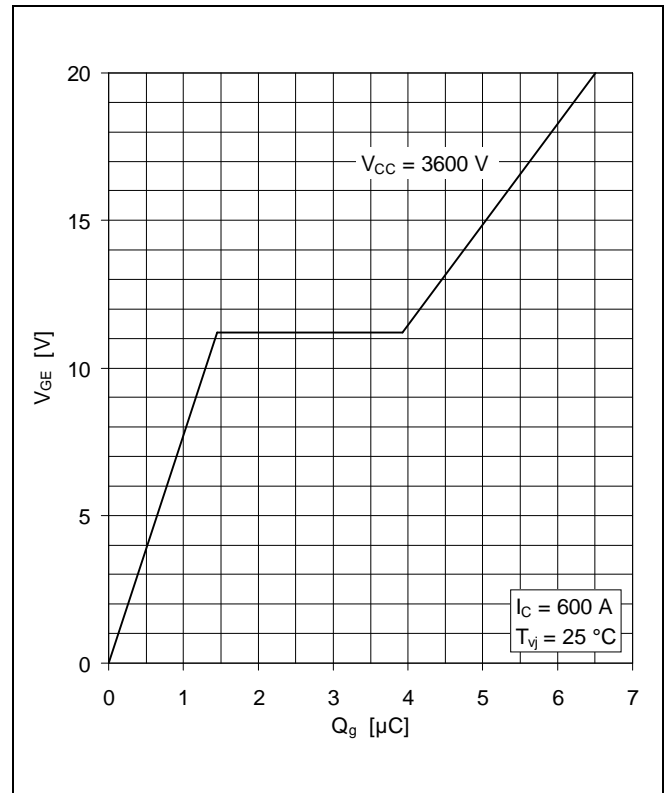


Fig. 10 Typical gate charge characteristics

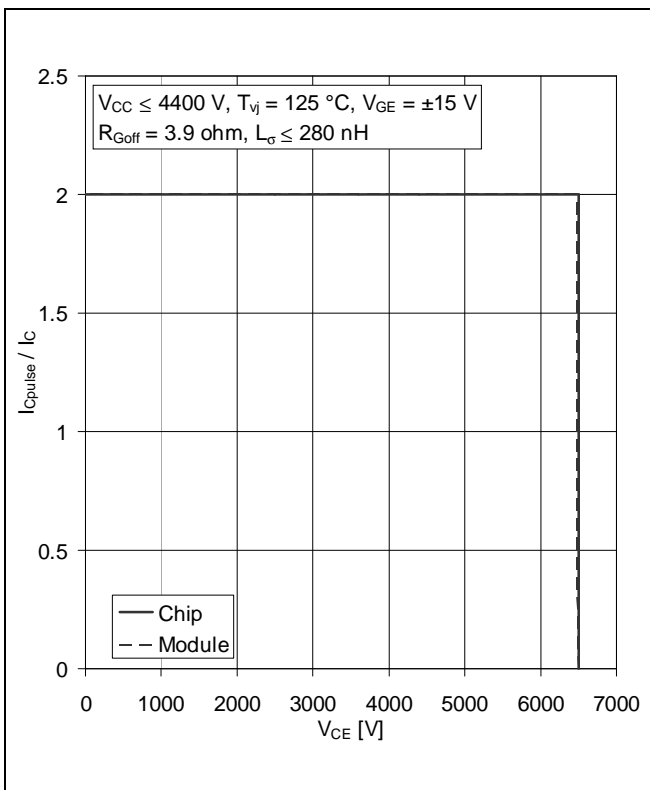


Fig. 11 Turn-off safe operating area (RBSOA)

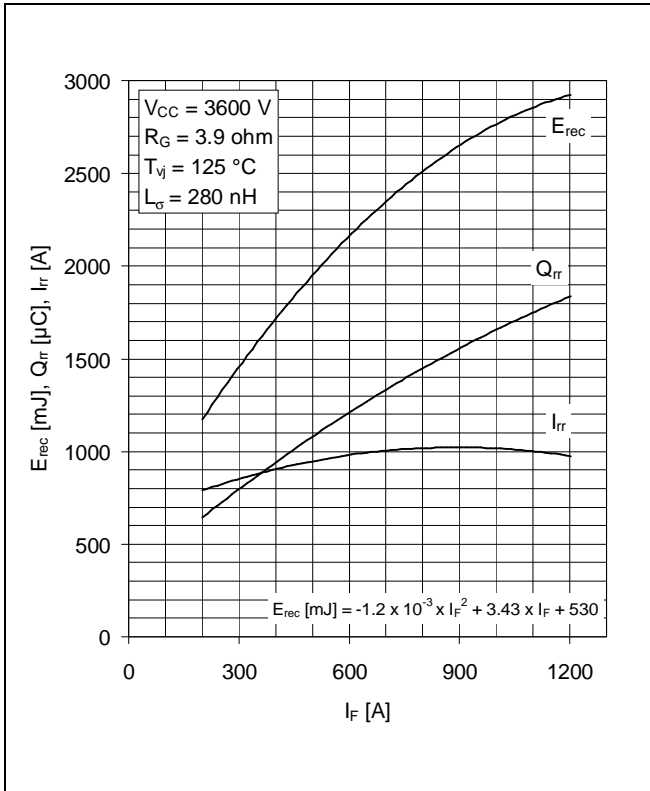


Fig. 12 Typical reverse recovery characteristics vs forward current

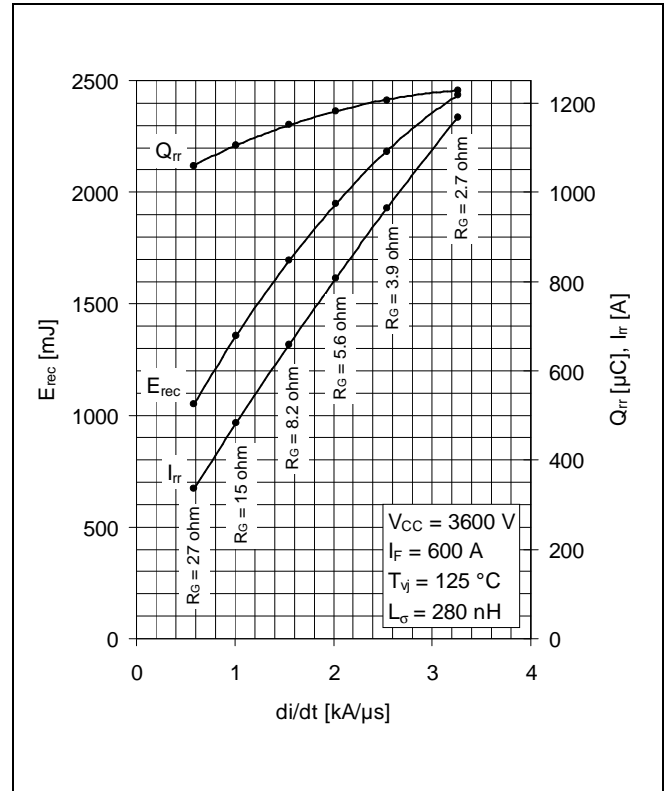


Fig. 13 Typical reverse recovery characteristics vs di/dt

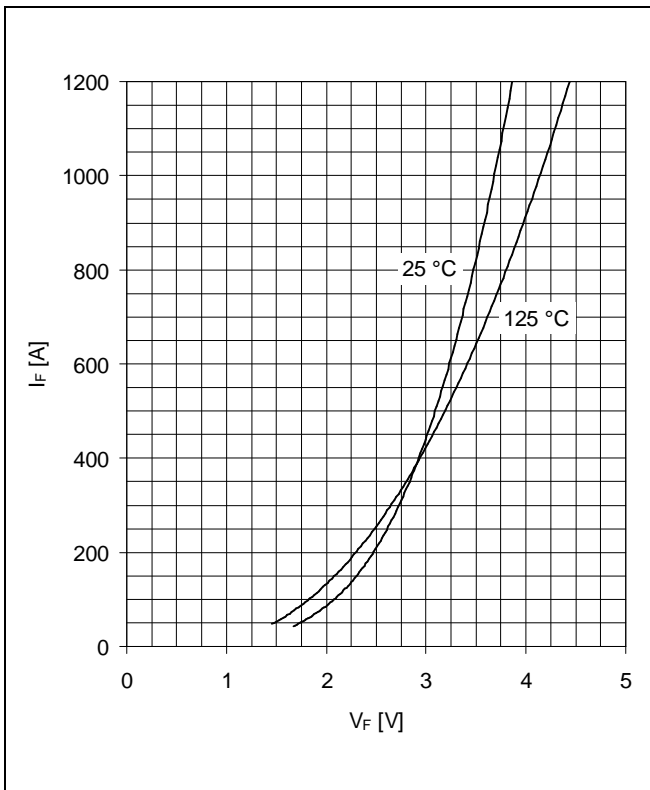


Fig. 14 Typical diode forward characteristics, chip level

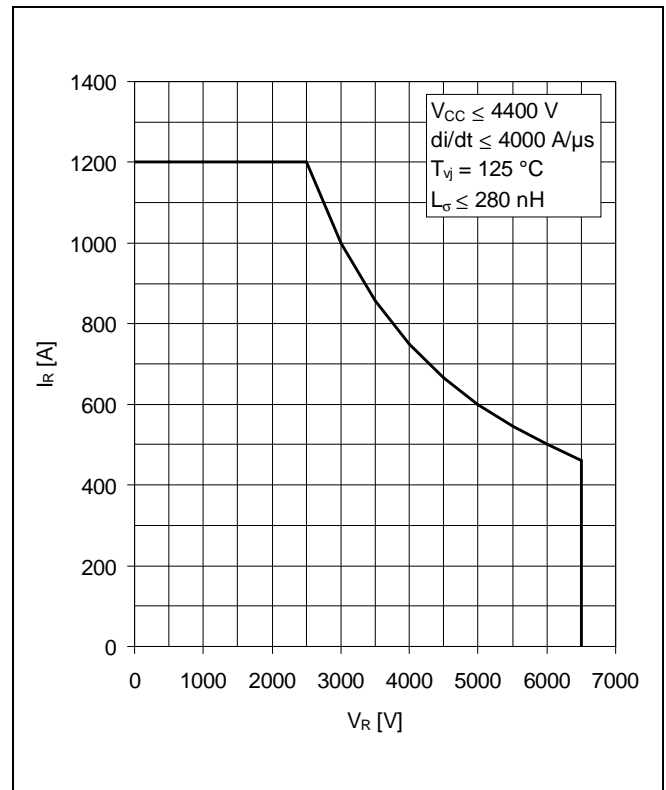


Fig. 15 Safe operating area diode (SOA)

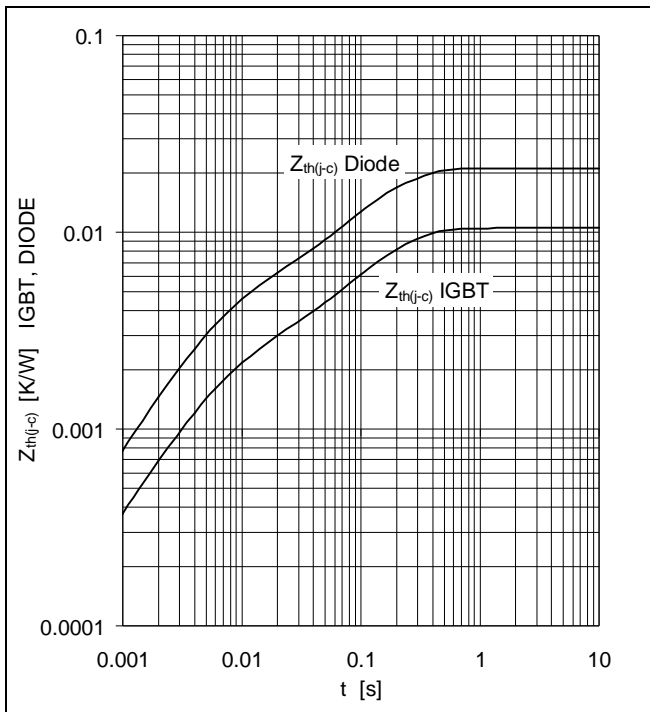


Fig. 16 Thermal impedance vs time

Analytical function for transient thermal impedance:

$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i (1 - e^{-t/t_i})$$

	i	1	2	3	4	5
IGBT	R_i (K/kW)	8.5	2			
	τ_i (ms)	151	5.84			
DIODE	R_i (K/kW)	17	4.2			
	τ_i (ms)	144	5.83			

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Doc. No. 5SYA1558-02 Jan 06